



QCA SERIES

ELECTRICAL & OPTICAL HIGH-SPEED COMMUNICATION ANALYZER

The **QCA Series High-Speed Communication Analyzer** is a digital equivalent-time sampling oscilloscope with a high-quality precision timebase and low jitter mode.

The QCA Series is designed to enable high-volume testing of electrical ICs and next-generation optical interconnects which are crucial to unlock high-performance computing (HPC) and remove large-scale AI connectivity bottlenecks.

With ultra-low jitter performance and unrivalled instrument density, it overcomes the scalability and cost-of-test limitations of traditional solutions by supporting parallel high-speed I/O testing.

Paired with our QCR Series clock recovery instruments, it delivers a cost-effective, scalable approach for accurate, high-throughput testing to reduce the cost-of test in high-volume manufacturing and design verification testing applications.

FEATURES



Ultra-low jitter

High quality precision timebase with low jitter mode provides ultra-low jitter noise floor and PLL-based low frequency clock phase tracking.



Electrical or optical

The QCA Series is available with either electrical or optical input options for precise waveform analysis.



Compact design

Compact design enables highdensity, high-channel count, test solutions in a relatively small footprint.



Scalable

Designed to meet the requirements for high channel count validation and high-volume manufacturing and testing.



Ease of integration

Small footprint, remote control and API enable easy integration into probing and assembly equipment.



Lower cost-of-test

Improved test efficiency and test throughput can reduce the cost-of test and accelerate timeto-market



Accurate performance

Comparable feature set and predictive value (correlation) as the prohibitively expensive R&D set-ups.



VISEYE™ software

The newly-designed visualization and analysis software has powerful analysis capabilities and is intuitive and easy-to-use.

WHY IS LOW JITTER AND HIGH-CHANNEL-DENSITY SO IMPORTANT?

Next-generation high-speed interconnects as well as novel, densely packed processing, compute and switch ASICs play a critical role in the roll-out of hyperscale data centers and emerging HPC and AI applications. These next-generation devices will contain hundreds of channels, each requiring testing at all stages of development, validation and manufacturing.

This development presents a set of new challenges for the test engineer: how to manage the cost-of-test, while meeting significantly increased test requirements? Densely-integrated technologies have a compressed point of failure – so skipping testing is not a viable option. All channels will need to be validated to make sure they meet specifications.

High-speed oscilloscopes have been used to test transmitters for many decades and the tried-and-tested eye diagram, and derived analysis such as TDECQ remain the primary performance measurement and are still a bottleneck in today's design, validation and manufacturing chain. At high baud rates, when jitter is combined with amplitude (or signal) noise, limited bandwidth, and multi-level signalling such as PAM4, timing deviations and signal integrity can get exponentially worse, and error-free transmission will be impossible if jitter is not controlled.

To be able to properly characterize the quality of high-speed interfaces, it is important that the jitter noise floor of the test instrumentation is low enough to be able to measure the jitter of the devices under test. It's also important that measurement equipment can track low frequency variations of the embedded clock in the high-speed signal. So-called clock wander is typical in link technologies that rely heavily on digital signal processing at the receiver or other advanced signalling formats.

Consequently, ultra-low jitter noise floor and PLL-based low frequency clock phase tracking are essential to provide the precision measurement conditions necessary for accurate and repeatable characterization of 100G per channel and above HSIO interfaces.

JITTER MATTERS!

CUSTOMERS & APPLICATIONS

QCA - Electrical

Developers of:

- · Switch ASICs
- GPUs/CPUs
- · AI/ML processing ICs
- · PAM4 DSP
- · Repeater/extender ICs
- Network switches/cards
- Other high-speed ICs: DACs, TIAs, and drivers etc.

Target applications:

- Transmitter characterization
- · High-volume test of high-speed ICs
- Validation testing (DVT)
- Pre-production testing
- · Switch port validation



Target applications:

QCA - Optical

Transceivers

Photonic ICs

Developers of:

Transmitter characterization

· Co-packaged optics (CPO)

In-package optical IOOptics for AI networks

· Systems integrators

- · High-volume test of high-speed PICs
- Validation testing (ODVT)
- Pre-production testing
- Transceiver validation







The QCA Series uses Quantifi Photonics' new VISEYE™ signal analysis software for an intuitive & easy-to-use experience to operate the oscilloscope and perform jitter and eye measurements.



VISEYE features a modern interface and has been designed to streamline the analysis process while providing full control of hardware and analysis functions. It also has a powerful API that allows streamlined automation for maximum measurement throughput.

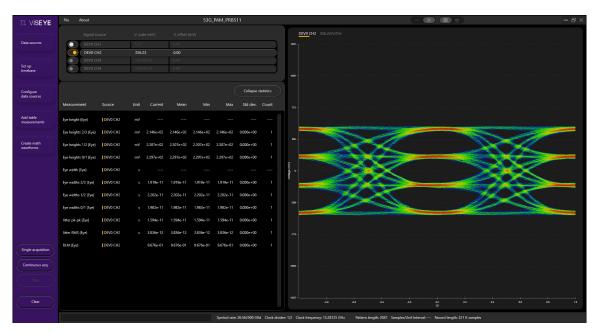
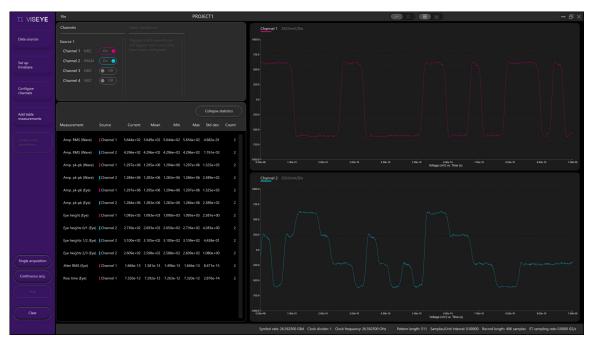


Image: 53 Gbps PAM4 signal eye diagram shown with numerical analysis parameters.



 $\textbf{Image:}\ 26\ \mathsf{GBaud}\ \mathsf{PAM4}\ \mathsf{trace}\ \mathsf{plot}\ \mathsf{shown}\ \mathsf{with}\ \mathsf{statistics}\ \mathsf{of}\ \mathsf{the}\ \mathsf{numerical}\ \mathsf{parameters}.$

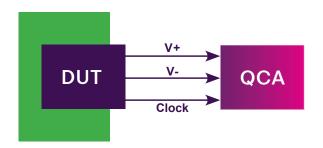
USE CASES - ELECTRICAL

Use case 1: Triggering using a synchronous clock

Signal types: 26.56 GBd PAM4, 25 - 32 G NRZ

Used for: Jitter and eye diagram measurements, fully synchronous Clock (to Tx)

*Can be used for 53.125 GBd PAM4 if local clock/PLL is available for triggering.

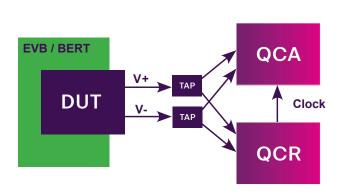


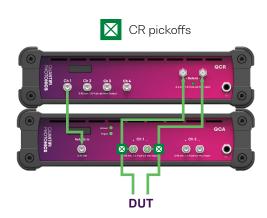


Use case 2: Triggering using a recovered clock

Ideal for: 53.125 GBd PAM4, 26.56 GBd PAM4, 25 - 32 G NRZ

Used for: Jitter and eye diagram measurements and Retimed Tx (local PLL)

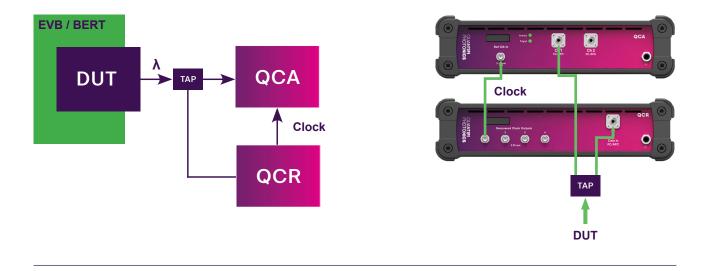




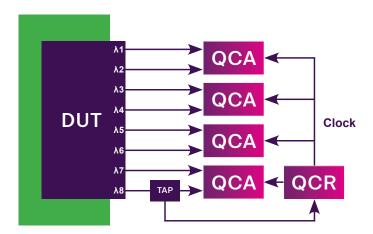
Use case 1: Triggering using a synchronized clock



Use case 2: Triggering using a recovered clock and optical tap



Use case 3: Triggering using a recovered clock and 8-channel DUT



DIMENSIONS

Front view - electrical



244 mm

Front view - optical



244 mm

Rear view



Side view



327 mm

QCA SERIES TECHNICAL SPECIFICATIONS

General Specifications	QCA
Dimensions (HxWxD)	60 x 244 x 327 mm 2.36 x 9.6 x 12.9 inches
Weight	2.71 kg
Bus connection	Ethernet
Number of channels	1 or 2
Operating temperature range	5 °C to 45 °C 41 °F to 113 °F
Storage temperature range	-40 °C to 70 °C -40 °F to 158 °F

Power Specifications	QCA
AC input voltage range	100 to 240 V
AC input current	1.3 A (115 V), 0.9 A (230 V)
AC frequency range	47 to 63 Hz

Model Number	1002	
Electrical QCA		
Coupling	AC-coupled, differential or single-ended	
Analog bandwidth (-3 dB)	50 GHz	
Equivalent-time sampling rate, max	3.5 MHz	
Pattern capture	Up to PRBS15	
Front panel RF connectors	2.4 mm	
RF termination	50 Ω (single-ended) 100 Ω (differential)	
Vertical		
Max input (damage threshold)	± 600 mV (each single-ended input)	
Linear dynamic range (AC-coupled)	± 500 mV (single-ended) 1000 mV _{pp} (differential)	
Vertical noise floor - diff.	1.4 mV (RMS)	
Ref Clock Trigger Input		
RF connector	2.92 mm (female)	
Nominal impedance	50 Ω AC-coupled	
Frequency range	5 - 16 GHz	
Maximum input amplitude (single-ended)	800 mV _{pp} (≥ 10 GHz) 600 mV _{pp} (< 10 GHz)	

QCA SERIES TECHNICAL SPECIFICATIONS

Model Number	1002
Jitter (for sinusoidal trigger input) ¹	
RMS jitter in low-jitter mode	150 fs
Jitter floor (trigger signal ≥ 10 GHz, ≥ 250 mV _{pp})	≤ 140 fs _{rms}
Jitter floor (trigger signal < 10 GHz, ≥ 350 mV _{pp})	≤ 160 fs _{rms}
Trigger sensitivity ²	75 mV _{pp} (≥ 10 GHz) 150 mV _{pp} (< 10 GHz)

Model Number	1102
Optical QCA	
Analog bandwidth (-3 dB)	44 GHz
Equivalent-time sampling rate, max	3.5 MHz
Pattern capture	Up to PRBS15
Optical connector type	FC/PC
Optical fiber type	SMF-28
Wavelength	1250 - 1650 nm
Vertical	
Max input (damage threshold)	10 mW
Amplitude accuracy (mW)	5%
Noise	4.8 μW _{rms}
Optical return loss (ORL)	15 dB
Ref Clock Trigger Input	
RF connector	2.92 mm (female)
Nominal impedance	50 Ω AC-coupled
Frequency range	7 - 14 GHz
Maximum input amplitude (single-ended)	800 mV _{pp} 600 mV _{pp} (7 - 14 GHz)

Notes

- 1. For channel signal input $\ge 300 \text{ mV}_{pp}$ 2. Pattern trigger and low-jitter timebase operational; jitter floor is degraded to $\le 190 \text{ fs}_{rms}$ (Typical.) 3. Preliminary specs as of May 2025 and subject to change.

VISEYE ADDITIONAL FEATURES

- Use up to eight sources of data, combined from the QCA instrument channels, captured waveform data files, or math waveforms.
- Show up to eight plots in a grid or stack view, in waveform mode or eye diagram mode.
- Use the project configuration file to capture your project settings to load it back easily for future use.
- Save your measurements results and statistics as a CSV file for further analysis.
- Configure the eye diagram plots Select the heat map type, eye accumulation type, and the desired saturation intensity.
- Apply chains of mathematical functions to existing sources.

Supported measurements

- · Amplitude average
- · Amplitude peak-peak
- · Amplitude RMS
- Decision Feedback Equalizer (DFE)*
- Eye amplitude
- Eye center amplitude
- Eye crossing percentage
- Eye height (NRZ/PAM4)
- · Eve one level
- Eye skews
- Eye width (NRZ/PAM4)

- Eye zero level
- Fall time
- · Jitter peak-peak
- Jitter RMS
- Levels
- · One/Zero levels
- Optical Extinction Ratio (ER)*
- Optical Modulation Amplitude (OMA)*
- Overshoot (NRZ/PAM4)
- · Rise time

- · Signal-to-noise ratio (SNR)
- Signal to Noise Distortion Ratio (SDNR)
- Symbol period (Bit rate)
- Transmitter Dispersion
 Eye Closure Quarternary
 TDECQ*
- Transmitter Dispersion Eye Closure TDEC*
- Transmitter linearity (RLM)
- · TDECQ filter*
- Undershoot (NRZ/PAM4)

Advanced math

- Continuous Time Linear Equalizer (CTLE)
- Linear Feed Forward Equalizer (FFE)
- S-parameter embedding and de-embedding (s2p file)

Math functions

- · Absolute value
- Add/subtract
- Align
- Amplify
- · Average*

- · Common mode
- · Delav*
- Difference
- Invert
- · Max./Min.*

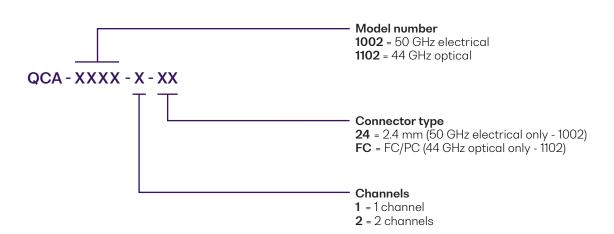
- Median*
- Multiply*
- · Square*
- · Square root*
- · Summation*

^{*}Future software updates will include additional measurement functions.

MINIMUM PC REQUIREMENTS

- · Operating system: Microsoft Windows® 10 (64-bit)
- Processor: Intel® CoreTM i9 or faster CPU
- · Memory: 32 GB or greater of RAM

ORDERING INFORMATION



Recommended auxiliary equipment:

Quantifi Photonics' QCR Clock Recovery Instrument.

WARRANTY INFORMATION

This product comes with a standard 1 year warranty.

EXTENDED WARRANTIES AND CALIBRATION PLANS

With an **extended warranty and calibration plan** you'll spend more time focused on your priorities and less time worrying about maintenance.

Add a **3 or 5 year extended warranty**when you purchase
your Quantifi Photonics
instruments.



Guarantee performance

Ensure your equipment is operating at the best it can be for reliable and accurate results.

Lower cost of ownership

Lock in savings and maximise your testing budget with a lower base cost of ownership.

Peace of mind

Spend less time worrying about maintenance and more on generating results.

CALIBRATION PLANS FOR ADDITIONAL DISCOUNTS

Order a **calibration plan** when purchasing your Quantifi Photonics instruments and get additional discounts.

10% Discount

On calibrations ordered at the time of purchase.

25% Discount

Add on an extended warranty and receive a 25% discount on calibrations.

Over time and with regular use, all optical parts and connectors require re-calibration and maintenance to guarantee accurate and reliable performance. We recommend Quantifi Photonics optical instruments are re-calibrated every 12 months. With an instrument calibration performed by Quantifi Photonics technicians you receive:

- Comprehensive calibration to factory specifications
- End-to-end inspection to ensure all instrument functions are working and connectors are clean
- Firmware, software and documentation updates
- Certificate of calibration which includes detailed test results

How to do I secure my extended warranty or calibration plan?

 $Contact\ your\ Quantifi\ Photonics\ sales\ representative\ or\ email\ \textbf{sales@quantifiphotonics.com}$

Extended warranties and calibration plans must be ordered at the time of purchase and are available only for Quantifi Photonics' products. The 25% calibration discount only applies to calibrations while the product is covered by the extended warranty period.

Our portfolio of optical & electro-optical test modules is rapidly expanding to meet a wide range of customer requirements and applications.

For more details visit quantifiphotonics.com/products

Tunable Laser Sources

Versatile telecom laser sources with full tunability across C or L bands. Narrow 100 kHz linewidth, up to 16.5 dBm of power, optional whisper mode to disable frequency dither.



Fixed Wavelength Laser Sources

Highly-customizable DFB or FP laser sources available in a wide range of wavelengths and powers up to 24 dBm.
Supports SMF, MMF and PMF.



Swept, Tunable Continuous Wave Laser

Swept, tunable continuous wave (CW) laser source with 0.01 dB power stability and 400 nm/s high-speed scan rate for R&D and production testing.





Superluminescent Diode Broadband Light Source

Super-luminescent LED light source with high output power, large bandwidth and low spectral ripple and various wavelengths.



Erbium-Doped Fibre Amplifier (EDFA)

High power Erbium-Doped Fiber Amplifier for signal power amplification in C and L bands with various control modes, including automatic agin control.



Variable Optical Attenuator (VOA)

Fast attenuation speed with low insertion loss and built-in power monitoring. Operates in fixed attenuation or constant output power modes. Support SMF, MMF and PMF.





Polarization Controller & Scrambler

High-speed automated polarization control with broad wavelength coverage from 1260nm to 1650nm, low insertion loss and back reflection. Full remote control via intuitive GUI, LabVIEW or SCPI.



Optical Power Meters

Fast terminating or inline monitoring of optical signal power from -60 to +10 dBm across 750 – 1700 nm wavelengths. Model with logarithmic analog output for applications such as silicon photonics fiber alignment.



Optical Spectrum Analyzer (OSA)

Cost-effective, spectral measurement in a compact module with built-in analysis for: SMSR, OSNR & spectral width. Targeted wavelengths for specific applications in O band, C band & L band





Optical-to-Electrical Converter

High bandwidth, broadband O-to-E converter. Available in a range of configurations; choose from 1 or 2 channels, AC or DC coupling and various conversion gain and operating wavelength ranges.



Digital Sampling Oscilloscope (DSO)

Digital equivalent-time sampling oscilloscope (DSO) with high-quality precision timebase and low jitter mode, available in 1 or 2 channels in a compact benchtop instrument.



Bit Error Rate Tester (BERT)

4 or 8-channel Pulse Pattern Generator and Error Detector at rates up to 29 Gbps for the design, characterization and production of optical transceivers and optoelectrical components.





Photonic Doppler Velocimeter (PDV)

Purpose-built module for Photonic Doppler Velocimetry (PDV). A circulator, two VOAs and a passive coupler all built into one compact module.



Optical Switch

Proven reliability and fast switching time. Wide variety of switch onfigurations: 1x4, 1x16, 16x16 and more. Models support SMF, MMF and PMF.



Photocurrent Amplifier

Versatile photodiode amplifier to measure photocurrent in photonic integrated circuit (PIC) applications. Digital and analog measurement.



Passive Component Integration

Integrate passive optical components of your choice such as WDM couplers, splitters, band-pass filters, PM beamsplitters and circulators. SMF, MMF and PMF.





Test. Measure. Solve.

Quantifi Photonics provides test solutions to help customers unlock scalable and cost-effective high-volume manufacturing of photonic integrated circuits (PICs), co-packaged optics and pluggable optics. The company's portfolio includes a wide range of photonic test instruments, and digital sampling oscilloscopes, available as benchtop or the industry-standard PXI format to support cost-effective, high-throughput design verification testing and high-volume manufacturing.

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